

Notice of References Cited	Application/Control No. 10/076,455	Applicant(s)/Patent Under Reexamination YAMADA ET AL.	
	Examiner Hoan H. Tran	Art Unit 2852	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,704,533	03-2004	Isomura et al.	399/254
	C	US-6,185,401	02-2001	Kanamori et al.	399/262
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	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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